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... brown or pdiff or pdiffusion, p-diffusion (p+ source/drain areas). blue or metal1 or m1, metal layer 1. ... and GND! for power supply rails. The ! ...
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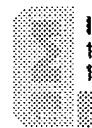
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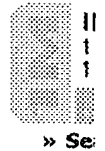
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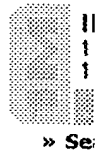
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